

Application/Control No.	Applicant(s)/Patent under Reexamination
10/801,940	BAEK ET AL.
Examiner	Art Unit

2883

Brian M. Healy

SEARCHED					
Class	Subclass	Date	Examiner		
385	122	3/27/2006	вмн		
	123				
	14				
	129				
	130				
	131				
65	385				
438	29,31				

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
SEARCH	3/27/2006	вмн			
NOTES					
	Subclass SEARCH	Subclass Date SEARCH 3/27/2006			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
SEARCHED "EAST" (SEARCH TERMS, CLASS/SUBCLASSES AND DATABASES RELIED UPON ARE LISTED ON PRINTOUT.)	3/27/2006	вмн
EAST SEARCH PRINTOUT ALSO INCLUDES INTERFERENCE SEARCH TERMS.	3/27/2006	вмн
PALM INVENTOR SEARCH	3/27/2006	вмн
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